

Observation and analysis of nano structures

Observation of nano-structures

The unique high power optics of JSM-7100F guarantees 1.2nm resolution. High magnification for the study of nano-structures is easily obtained.

Stable high precision analysis

The in-lens thermal FEG produces a stable large probe current. You can obtain high quality observation and analysis results. The emitter is guaranteed for 3 years.

Magnetic specimens

The objective lens of the JSM-7100F does not form magnetic field around a specimen. Magnetic specimens can be observed and analyzed without restriction.



Analysis of nano-structures

A small probe diameter is obtained with the patented aperture angle optimizing lens. You can acquire high precision analyses and high quality elemental maps in a short time by using a large probe current.

A variety of analytical equipment including EDS, WDS, and EBSD can be mounted with their ideal geometry.

Clean vacuum

A specimen is introduced through the specimen exchange airlock chamber. The specimen chamber is always kept in a clean high vacuum. The unique one action specimen exchange mechanism lets you insert and remove a specimen with a simple operation. The specimen chamber is pumped with a TMP.



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